



IECQ QUALITY ASSESSMENT SYSTEM (IECQ)

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IECQ Certificate of Approval Independent Testing Laboratory

IECQ Certificate No.:	IECQ-L ULTW 16.0003-16	Issue No.:	2	Status:	Current
Additional Site to Certification: IECQ-L ULTW 16.0003		Originally Issued: 2016/07/28			
Supersedes:	IECQ-L ULTW 16.0003-16 Issue 1	Issue Date:	2025/07/10	Site Added:	2024/09/03
CB Reference No.:	50600599 ITL	Expiration:	2028/07/27		

Materials Analysis Technology (SuZhou) Ltd.

101, Building 2 Zone 5 Chinese Sciences Nanoscience Industrialization Base, No. 128 Fangzhou Road, Suzhou Industrial Park,
361000 Suzhou City, Jiangsu Province
China

The organization, facilities and procedures have been assessed by the IECQ Certification Body in accordance with IECQ 03-1 and IECQ 03-6 for issuance of this certificate and found to be in conformity with the applicable requirements of the IECQ Independent Testing Laboratory Assessment Program Requirements Scheme and in respect of ISO/IEC 17025:2017 for the testing of component product under the IECQ.

Scope:

The provision of materials analysis and failure analysis services of semiconductors.
See attached Schedule

-- Attached Schedule: IECQ-L_ULTW_50600599 ITL_07-10-25.pdf --

Approved by Certification Body (CB): DQS Group - DQS Taiwan Inc.

8F, 23, Yuan Huan West Road,
Feng Yuan Dist., Taichung City
Taiwan

Authorized person:
Bob CHEN



The validity of this certificate is maintained through on-going surveillance audits by the IECQ CB issuing this certificate.
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Schedule of Scope to Certificate of Approval Independent Testing Laboratory

IECQ Certificate No.: IECQ-L ULTW 16.0003-16

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Schedule Number: IECQ-L ULTW 16.0003-16-S Rev No.: 2 Revision Date: 2025/07/10 Page 1 of 1

Appendix-1 (50600599 ITL) Schedule of Scope to Certificate of Approval

Tests	Standards/Procedures
Scanning Electron Microscope (SEM)	T-SEM-3
EMMI-InGaAs	T-EFA-3
Focused Ion Beam Microscope (FIB)	T-FIB-3
Optical Microscope (OM)	T-OMI-3
3D Optical Microscope	T-LAB-3
Chemical Treatment	T-LAB-3
2D X-Ray imaging	T-EFA-3
Optical Beam Induced Resistance Change (OBIRCH)	T-EFA-3
Scanning Acoustic Tomography (SAT)	T-EFA-3
THEMOS	T-EFA-3

Technical Reviewer of DQS: Paul Yang Date: 7/10/2025

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